AXIe : AdvancedTCA[®] Extensions for Instrumentation and Test

Overview



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AXIe: What and Why

• What is it?

 An open system modular instrumentation standard based on AdvancedTCA[®], that delivers high performance instrumentation for aerospace defense, high energy physics, semiconductor test and other industries.

What advantages does it bring?

- "Big brother to PXI." Same PCIe fabric and programming, but with:
- Horizontal configurations for minimal rack space, vertical for large systems
- Larger boards for highest rack and power densities per rack inch
- High speed trigger, timing, and local bus
- Semiconductor test extensions
- ATCA compatibility
- Optional LAN fabric
- Integrates easily with PXI, LXI and IVI





LXI, PXI, and AXIe Rack and Stack System



AXIe + PXI Semiconductor Test System

AXIe compatibility and scalability

PXI (30 Watts) AXIe (200 Watts)



- Embedded or external
- Standard I/O

AXIe brings critical functionality to Mil/Aero systems in a dense and powerful form factor

Image: Cle Ima

Software

 Common software drives PXI and AXIe

Controllers

- Embedded or external
- PCIe is common interface
 for PXI and AXIe

Very high performance instrumentation expands performance envelope of modular platforms in 4U chassis





AXIe brings powerful and cost effective new technology to digital verification and test



AXIe delivers leading edge verification tools including:

- PCIe Gen 1,2,3 exerciser and analyzer
- HDMI 1.4 analyzer
- Industry's fastest logic analyzer
- DDR3 analysis





AXIe digitizers and AWGs deliver industry leading performance for mixed-signal test:

- Digitizers range from 1.6Gs/s @12 bits to 40Gs/s @ 8 bits
- AWGs deliver 8Gs/s @ 14 bits to 12Gs/s @ 12 bits
- Powerful and complex
 waveform creation and analysis



AXIe + PXI Semiconductor Test System offers cost effective alternative to "big iron" testers for small scale manufacturing and design verification



AXIe brings world-class measurements and density to Big Physics



AXIe is the next logical step in modular instrumentation for physics AXle



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- Powerful and complex waveform creation and analysis

AXIe brings unprecedented rack density to high speed digitizers

AXIe is built upon the ATCA standard, enabling a platform for end user customization.

4U Rack Height:



40 channels of 1.6Gs/s



20 channels of 10Gs/s



Waveform Capture and Generation



Why AdvancedTCA as a foundation?

- AdvancedTCA PICMG[®] 3.0 Specification: *proven* open system architecture
- Large board size
 - Ideal for high performance instrumentation
 - Board size matches that of planar instrument design
 - Exceptional cooling
- Rack space efficiency
 - Horizontal and vertical configurations
- Scalability
 - 1 slot to 16 slots, 1 Chassis to many, PXI/PCI adapters
- Ideal for high power applications
 - Single rail power management and robust cooling
- Virtual LXI and PXI
 - Base fabric support of LAN, data fabric support of PCIe
- Robust system management
 - Intelligent Platform Management Interface (IPMI) enables both single chassis and multi-chassis system control functions
- Extensions for I/O allow Zone 3 definitions for identified vertical markets



AdvancedTCA Shelf (Chassis)

- 2-16 Slot Shelf
 - 2-14 Slots in 19" Rack
- 2 Hub Slots
- 14 Node Slots
- User Zone 3 Backplane
- LAN routed to every slot
- PICMG 3.4: PCIe to every slot
- Large form factor cards
- Flexible power (48V) and air cooled design

Zone 3 Zone 2

Zone 1



AXIe Specification Structure

AXIe is a scalable family of specifications allowing a portfolio of applications.

AXIe-3.n Zone 3 Definitions	Semiconductor <u>Test</u> AXIe-3.1 • Zone 3 signals • DUT I/O on RTM • Add'I Trigger/Sync	Other future Apps AXIe-3.n • For future expansion	 AXIe-3.n specifications define Zone 3 capabilities for specific markets Can define specific additional system management and resources May work on top of a standard ATCA topologies or AXIe-1
AXIe-2 Software	 Software Specification Enables AXIe to appear as PXI to a resource manager 		AXIe adds a software specification that makes AXIe appear almost exactly as a PXI system
AXIe-1 Zone 1+2 Topology	 AdvancedTCA plus Triggers and Timing Local Bus 		• AXIe expands allowable ATCA Zone 1 and 2 topologies to include AXIe-1, allowing embedded data transfer and synchronization
ATCA	 AdvancedTCA PICMG3.0, PICMG3.4 LAN + PCIe System Management 		ATCA is the base specification for all AXIe specifications



AXIe leverages ATCA



AdvancedTCA

- AdvancedTCA specific extensions
- IPMI and resource management
- Timing and Sync
- Zone 3 configurations

...draws from and works with existing instrument standards

PXI

- Virtual PXIe instruments
- PCIe communication

IVI Standard drivers work in all Application

Development Environments

• VISA specifications

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- Virtual LXI instruments
- LAN communication



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High scalability of AXIe

14 slot Vertical







n U Horizontal



Specialty instrument with AXIe module



PXI carrier module



AXIe integration with Rack and Stack

GP-IB Instruments





AXIe-1 exploits unique bus topologies



AXIe-1 adds Timing and Triggering to ATCA



AXi_e

AXIe-1 adds a High-Speed Local Bus to ATCA



Proven performance at 40GB/s using today's technology



Local bus enables simultaneous high speed streaming between modules



AXie

Local bus enables very fast streaming between digitizers, DSP, and waveform generators



- 40GB/s today, more in future
- External RAID for nearly indefinite streaming
- Nearly endless number of configurations

AXIe is the "Big Brother" of PXI

Feature	AXIe	PXIe
Chassis base	AdvancedTCA	cPCI/cPCIe
PCIe maximum data bandwidth (Maximum Gen 2.0): Single peripheral slot to backplane All peripheral slots to system slot	2 GB/s 26 GB/s	4 GB/s 8 GB/s
PCIe fabric	Yes	Yes
LAN backplane	Yes	No
Local bus	62 differential pairs	1 line (13 PXI)
Triggers	Bidirectional Star Trigger 12 signal MLVDS bus	Star Trigger(1xTTL, 3x Diff per slot) 8 Signal TTL bus
Frequency Reference & Sync	100MHz, yes	10MHz, 100MHz, yes
Power per slot	200 W	30 W
Board space per slot (higher density, flexibility)	900 cm ²	160 cm ²
Modules available	New	~1100



Horizontal AXIe compared with PXI The tale of two 4U chassis:





Total module board area
Total module volume
Total module power

 $5 \times 900 = 4500 \text{ cm}^2$ $4500 \times 3 = 13500 \text{ cm}^3$ $200W \times 5 = 1000 \text{ W}$ $17 \times 160 = 2720 \text{ cm}^2$ $2720 \times 2 = 5440 \text{ cm}^3$ $17 \times 30 = 510 \text{ W}$



AXIe-3.1 Vision

- Provide an instrumentation environment that reduces the overall cost of test for the Semiconductor Product Test Process.
- Bridge the gap between Device Characterization and high volume Production Test
- Provide Semiconductor ATE instrumentation for Device Characterization
 - High Speed Digital Pins
 - DC & Power Instrumentation





AXIe-3.1 Semiconductor Test Requirements

- Mass Terminated instrument IO mating
 - Managed device test fixtures with quick disconnect
- In Situ system maintenance Diagnostics and Calibration.
 - System Checkers
 - Field Calibration
- High Channel Count Instrumentation
 - 1000's of digital pins
 - 100's of DC power supplies
- Support for single site Characterization AND high volume Multi-Site production



AXIe-3.1 Extensions

- Timing and Triggering Extension
 - Quad Bi-Directional Star Trigger to Each Slot
 - Digital Channel Vender-Defined Synchronization
- Test Fixture Support
 - Instrument I/O via Rear Transition Modules
 - DUT Load Board
 - Modular Checker Load Boards
 - Instrument Calibration Load Boards
- Field Calibration Path
 - External NIST traceable instruments
 - 4 Wire Kelvin Calibration Bus to each slot
 - I Amp, 300 Volt Max



Example Zone 3 backplanes



AXIe-3.1 Synchronization

• Instrument Triggering

- 4 Star Triggers from System Module to each Instrument node
- Non blocking Bi-directional Differential Terminated BLVDS
- Single Source to Many destinations
- Chassis to Chassis synchronization via System Module

Pattern Based Synchronization: UserSync

- 5 star-distributed signals from System Module to each Instrument node for Pattern Based Synchronization
- Digital Pattern Synchronization between Digital Instruments and Analog Instruments.
- Up to 4 Synchronized Chassis



Summary

- Extending AdvancedTCA
 - AXIe is based on AdvancedTCA with extensions for instrumentation and test.
- General Purpose (AXIe-1), Base Software Specification (AXIe-2), & Semiconductor Test (AXIe-3.1)
 - Family of standards
- More Performance, Scalability, Flexibility
 - AXIe delivers higher performance in a flexible, scalable platform.

• PXI, LXI, IVI

- AXIe works well with other standards, such as PXI, LXI and IVI.
- "Big Brother of PXI"
- Specifications may be downloaded from the AXIe Consortium website at <u>www.axiestandard.org</u>

